

# FDD8870 / FDU8870 N-Channel PowerTrench<sup>®</sup> MOSFET 30V, 160A, $3.9m\Omega$

#### **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conven tional swit ching PW M controllers. It has been optimized for low gate charge, low  $r_{\text{DS}(\text{ON})}$  and fast switching speed.

(TO-252)

#### Applications

DC/DC converters

## Features

- $r_{DS(ON)}$  = 3.9m $\Omega$ ,  $V_{GS}$  = 10V,  $I_D$  = 35A
- r<sub>DS(ON)</sub> = 4.4mΩ, V<sub>GS</sub> = 4.5V, I<sub>D</sub> = 35A
- High performance trench technology for extremely low  $\ensuremath{^r_{\text{DS}(\text{ON})}}$
- Low gate charge
- High power and current handling capability



March 2015

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MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units V	
V <sub>DSS</sub>	Drain to Source Voltage	30		
V <sub>GS</sub>	Gate to Source Voltage	<u>+2</u> 0	V	
ID	Drain Current			
	Continuous (T <sub>C</sub> = 25 <sup>o</sup> C, V <sub>GS</sub> = 10V) (Note 1)	160	Α	
	Continuous ( $T_C = 25^{\circ}C$ , $V_{GS} = 4.5V$ ) (Note 1)	150	Α	
	Continuous ( $T_{amb}$ = 25°C, $V_{GS}$ = 10V, with $R_{\theta JA}$ = 52°C/W)	21	Α	
	Pulsed	Figure 4	Α	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 2)	690	mJ	
P <sub>D</sub>	Power dissipation	160	W	
	Derate above 25°C	1.07	W/ºC	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-55 to 175	°C	

GDS

$R_{ extsf{ heta}JC}$	Thermal Resistance Junction to Case TO-252, TO-251	0.94	°C/W
$R_{\thetaJA}$	Thermal Resistance Junction to Ambient TO-252, TO-251	100	°C/W
$R_{ hetaJA}$	Thermal Resistance Junction to Ambient TO-252, 1in <sup>2</sup> copper pad area	52	°C/W

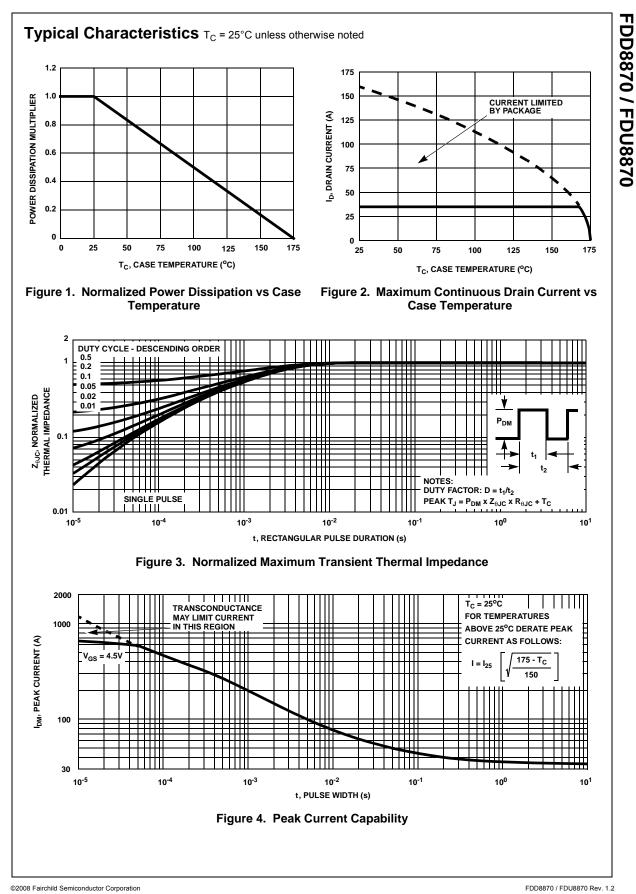
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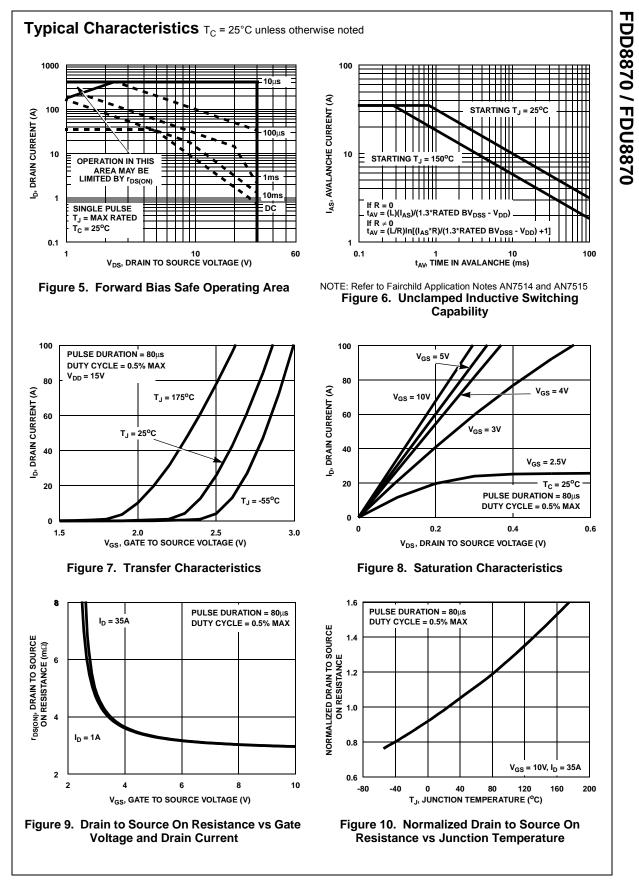
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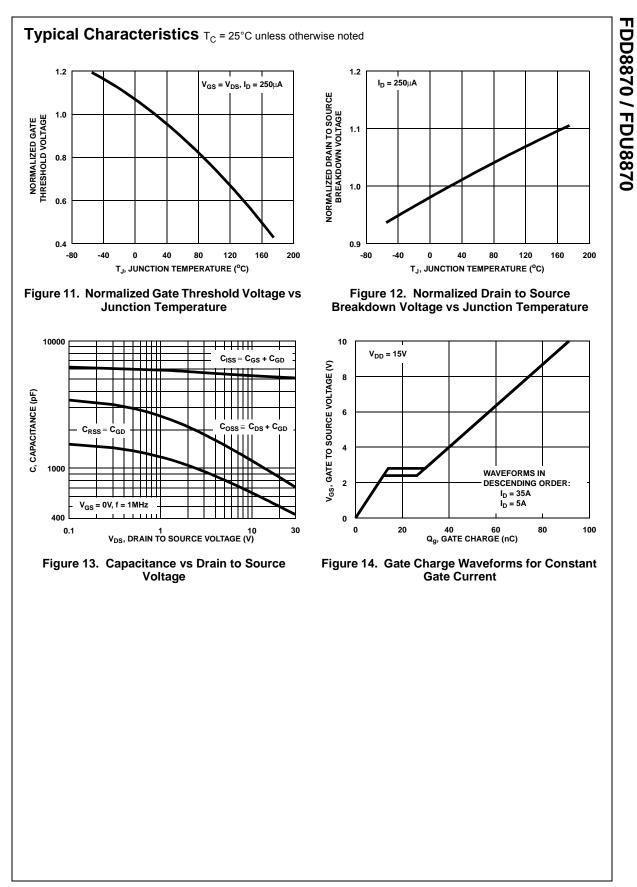
Device Marking FDD8870		ing Device Pac		Reel Size	Tape Width		Quantity	
		FDD8870	TO-252AA	13"	16r	nm	2500 units	
FDU8870		FDU8870	TO-251AA Tube		N/A		75 units	
Electric	al Chara	acteristics T <sub>C</sub> = 25°C	C unless otherwis	se noted				
Symbol	Parameter		Test Conditions		Min	Тур	Max	Units
Off Chara	cteristics	;						
B <sub>VDSS</sub>	Drain to So	ource Breakdown Voltage	I <sub>D</sub> = 250μA,	V <sub>GS</sub> = 0V	30	-	-	V
1	Zoro Cato	Voltage Drain Current	V <sub>DS</sub> = 24V		-	-	1	
IDSS	Zelo Gale	Voltage Drain Current	$V_{GS} = 0V$	T <sub>C</sub> = 150°C	-	-	250	μA
GSS	Gate to So	urce Leakage Current	V <sub>GS</sub> = ±20V	·	-	-	±100	nA
On Chara	cteristics	i						
V <sub>GS(TH)</sub>		urce Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> ,	<sub>D</sub> = 250μA	1.2	-	2.5	V
			I <sub>D</sub> = 35A, V <sub>G</sub>		-	0.0032	0.0039	
	Drain to Sc	uraa On Basistanaa	I <sub>D</sub> = 35A, V <sub>G</sub>		-	0.0036	0.0044	~
DS(ON)	Diam to St	ource On Resistance	I <sub>D</sub> = 35A, V <sub>G</sub> T <sub>J</sub> = 175 <sup>o</sup> C		-	0.0051	0.0063	Ω
Dynamic	Characte	ristics						
C <sub>ISS</sub>	Input Capa	citance				5160	-	pF
C <sub>OSS</sub>	Output Car	pacitance				990	-	pF
C <sub>RSS</sub>		ansfer Capacitance	f = 1MHz		-	590	-	pF
R <sub>G</sub>	Gate Resis	stance	V <sub>GS</sub> = 0.5V,	f = 1MHz	-	2.1	-	Ω
Q <sub>g(TOT)</sub>	Total Gate	Charge at 10V	V <sub>GS</sub> = 0V to		-	91	118	nC
Q <sub>g(5)</sub>	Total Gate	Charge at 5V	V <sub>GS</sub> = 0V to	5V	-	48	62	nC
Q <sub>g(TH)</sub>	Threshold	Gate Charge	V <sub>GS</sub> = 0V to	$1V$ $V_{DD} = 15V$	-	5	6.5	nC
Q <sub>gs</sub>	Gate to So	urce Gate Charge		l <sub>D</sub> = 35A l <sub>a</sub> = 1.0mA	-	14	-	nC
Q <sub>gs2</sub>	Gate Char	ge Threshold to Plateau		ig = 1.011A		9	-	nC
Q <sub>gd</sub>	Gate to Dra	ain "Miller" Charge			-	18	-	nC
Switching	Charact	eristics (V <sub>GS</sub> = 10V)						
t <sub>ON</sub>	Turn-On Ti				-	-	139	ns
t <sub>d(ON)</sub>	Turn-On De	elay Time		V <sub>DD</sub> = 15V, I <sub>D</sub> = 35A V <sub>GS</sub> = 10V, R <sub>GS</sub> = 3.3Ω		9	-	ns
t <sub>r</sub>	Rise Time		Vpp = 15V. I			83	-	ns
t <sub>d(OFF)</sub>	Turn-Off De	elay Time				83	-	ns
t <sub>f</sub>	Fall Time				-	42	-	ns
t <sub>OFF</sub>	Turn-Off Ti	me		-		-	189	ns
		e Characteristics						
V <sub>SD</sub>			las = 35A		-	-	1.25	V
	Source to Drain Diode Voltage	I <sub>SD</sub> = 35A I <sub>SD</sub> = 15A		-	-	1.25	V	
t <sub>rr</sub>	Reverse R	ecovery Time	I <sub>SD</sub> = 35A, d	-	-	37	ns	
Q <sub>RR</sub>		ecovered Charge		I <sub>SD</sub> /dt = 100A/μs	-	-	21	nC
lotes:	ent limitation is 3	0				1		

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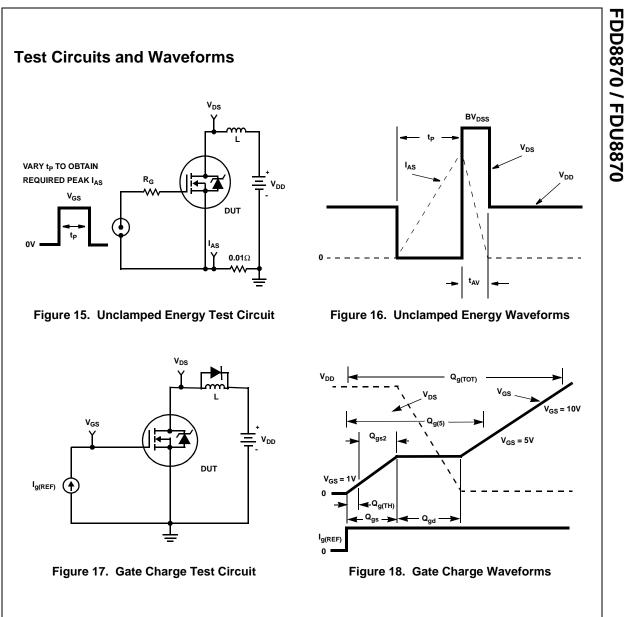




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VDS

V<sub>GS</sub>

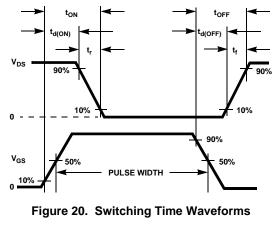
Figure 19. Switching Time Test Circuit

R<sub>GS</sub> ₹

 $R_L$ 

DUT

 $V_{DD}$ 



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### Thermal Resistance vs. Mounting Pad Area

The max imum rated junct ion temperature, T  $_{JM}$ , and t he thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation,  $\mathsf{P}_{\mathsf{DM}}$ , in an application. Therefore t he application's ambient temperature,  $T_A$  (°C), and thermal resistance  $R_{\theta,JA}$  (°C/W) must be rev iewed to ensure that T  $_{\mbox{JM}}$  is never ex ceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$
(EQ. 1)

In us ing surf ace m ount dev ices s uch as t he T O-252 package, the environment in which it is applied will have a significant inf luence on t he part's cur rent and m aximum power dissipation ratings. Precise determination of P<sub>DM</sub> is complex and influenced by many factors:

- 1. Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board
- 2. The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4 The use of thermal vias
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

Fairchild provides t hermal i nformation t o as sist the designer's preliminary application evaluat ion. F igure 21 defines the R <sub>0.1A</sub> for the device as a function of the top copper (component s ide) area. T his is f or a horizont ally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state iunction temperature or power dissipat ion. P ulse applications can be ev aluated us ing the F airchild device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

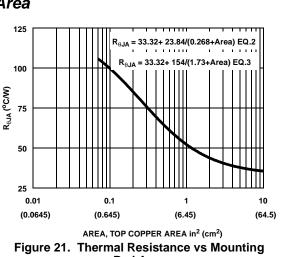
Thermal resistances corresponding to other copper areas can be obt ained from Figure 21 or by calc ulation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeters square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

$$R_{\theta JA} = 33.32 + \frac{23.84}{(0.268 + Area)}$$
(EQ. 2)

Area in Inches Squared

$$R_{\Theta JA} = 33.32 + \frac{154}{(1.73 + Area)}$$
 (EQ. 3)

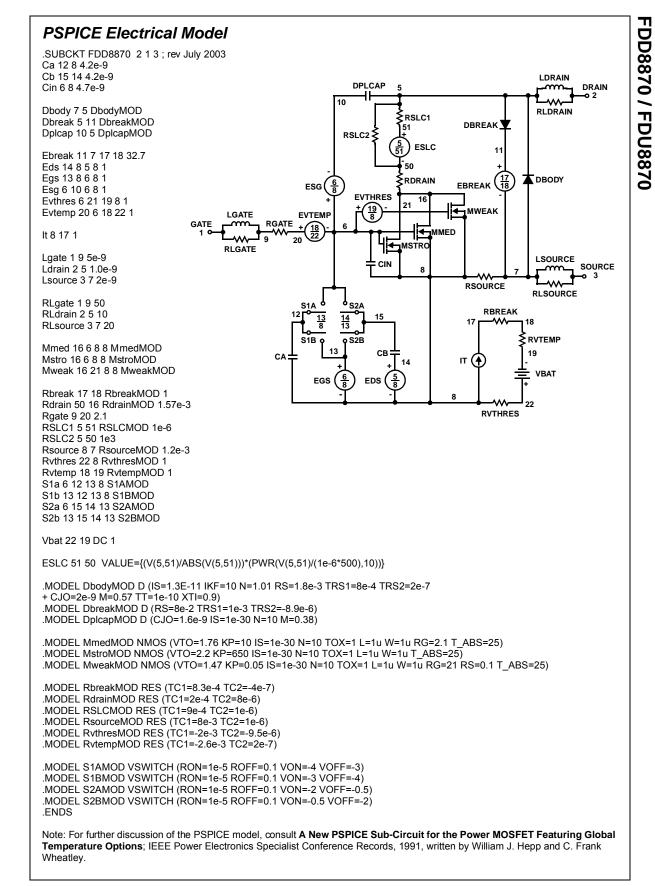
Area in Centimeters Squared



FDD8870 / FDU8870

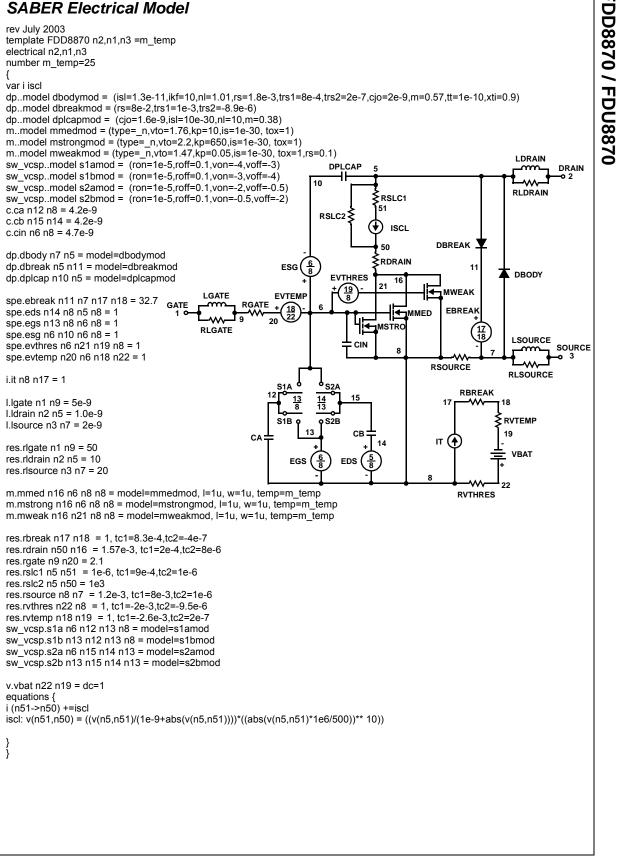


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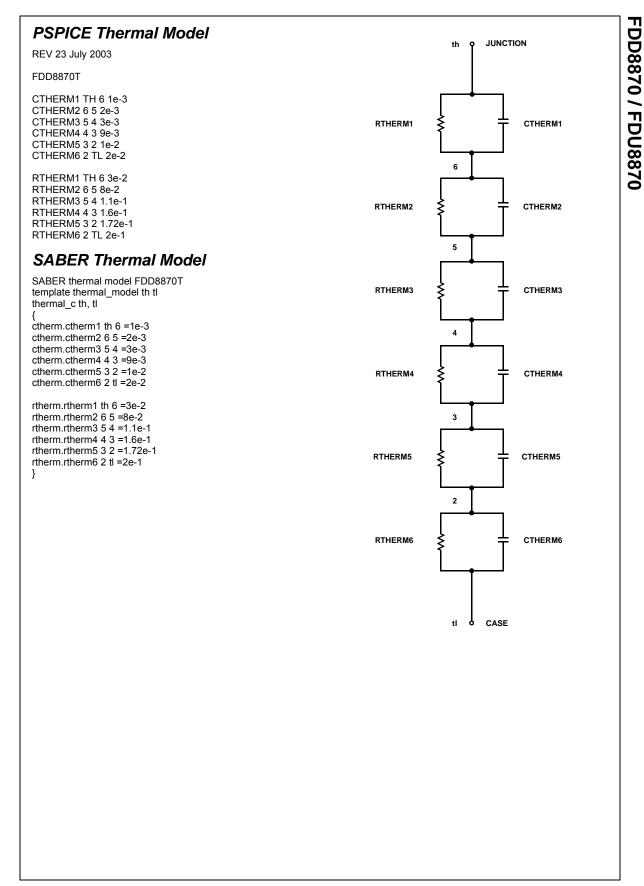


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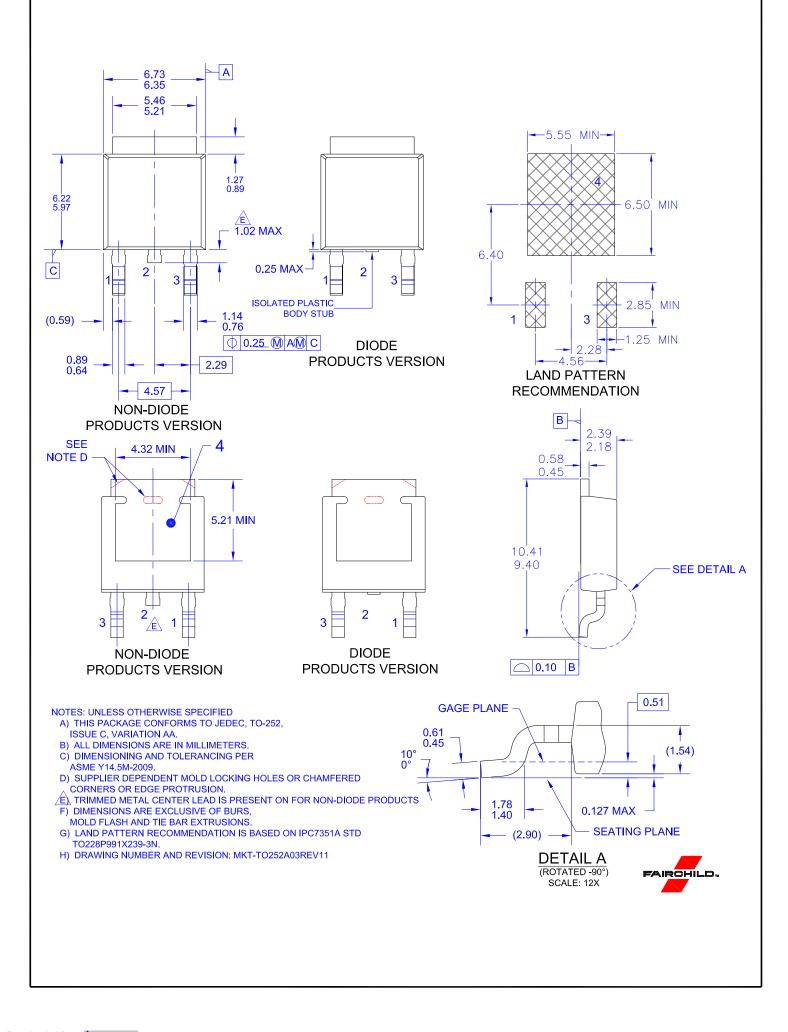
## SABER Electrical Model



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